# **BLC10G18XS-400AVT**

# Power LDMOS transistor

**AMPLEON** 

Rev. 1 — 19 April 2018

Product data sheet

# 1. Product profile

### 1.1 General description

400 W LDMOS packaged asymmetric Doherty power transistor for base station applications at frequencies from 1805 MHz to 1880 MHz.

#### Table 1. Typical performance

Typical RF performance at  $T_{case}$  = 25 °C in an asymmetrical Doherty demo circuit ( $V_{DS}$  = 32 V) and production circuit ( $V_{DS}$  = 28 V);  $I_{Dq}$  = 860 mA (main);  $V_{GS(amp)peak}$  = 0.7 V, unless otherwise specified.

Test signal	f	V <sub>DS</sub>	P <sub>L(AV)</sub>	Gp	ησ	ACPR
	(MHz)	(V)	(W)	(dB)	(%)	(dBc)
1-carrier W-CDMA	1805 to 1880	28	56	16.5	49.0	-29.7 [1]
	1805 to 1880	32	93	17.0	49.5	-29.5 [1]

<sup>[1]</sup> Test signal: 1-carrier W-CDMA; 3GPP test model 1; 64 DPCH; PAR = 9.9 dB at 0.01 % probability on CCDF.

#### 1.2 Features and benefits

- Excellent ruggedness
- High efficiency
- Low thermal resistance providing excellent thermal stability
- Lower output capacitance for improved performance in Doherty applications
- Designed for low memory effects providing excellent digital pre-distortion capability
- Internally matched for ease of use
- Integrated ESD protection
- For RoHS compliance see the product details on the Ampleon website

#### 1.3 Applications

RF power amplifiers for base stations and multi carrier applications in the 1805 MHz to 1880 MHz frequency range

# 2. Pinning information

Table 2. Pinning

Pin	Description		Simplified outline	Graphic symbol
1	drain2 (peak)			0.7
2	drain1 (main)		7 2 1 6	2, 7
3	gate1 (main)		5	<u> </u>
4	gate2 (peak)		3 4	3——5
5	source	[1]		4—
6	video decoupling (peak)			" <del>'</del> ¬
7	video decoupling (main)			1, 6 aaa-014884

<sup>[1]</sup> Connected to flange.

# 3. Ordering information

Table 3. Ordering information

Type number	Package					
	Name	Description	Version			
BLC10G18XS-400AVT	-	air cavity plastic earless flanged package; 6 leads	SOT1258-4			

# 4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DS}$	drain-source voltage		-	65	V
V <sub>GS(amp)main</sub>	main amplifier gate-source voltage		-6	+9	V
V <sub>GS(amp)peak</sub>	peak amplifier gate-source voltage		-6	+9	V
T <sub>stg</sub>	storage temperature		-65	+150	°C
Tj	junction temperature	[1]	-	225	°C
T <sub>case</sub>	case temperature	operating [1]	-40	+125	°C

<sup>[1]</sup> Continuous use at maximum temperature will affect the reliability, for details refer to the online MTF calculator.

# 5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Тур	Unit
R <sub>th(j-c)</sub>	thermal resistance from junction to case	V <sub>DS</sub> = 32 V; I <sub>Dq</sub> = 800 mA (main); V <sub>GS(amp)peak</sub> = 0,4 V; T <sub>case</sub> = 80 °C		
		P <sub>L</sub> = 56 W	0.32	k/W
		P <sub>L</sub> = 74 W	0.3	k/W

BLC10G18XS-400AVT

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### 6. Characteristics

 Table 6.
 DC characteristics

 $T_i$  = 25 °C unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Main dev	rice					
V <sub>(BR)DSS</sub>	drain-source breakdown voltage	$V_{GS} = 0 \text{ V}; I_D = 1.44 \text{ mA}$	65	-	-	V
V <sub>GS(th)</sub>	gate-source threshold voltage	V <sub>DS</sub> = 10 V; I <sub>D</sub> = 144 mA	1.5	2.0	2.5	V
$V_{GSq}$	gate-source quiescent voltage	V <sub>DS</sub> = 28 V; I <sub>D</sub> = 800 mA	-	2.2	-	V
I <sub>DSS</sub>	drain leakage current	V <sub>GS</sub> = 0 V; V <sub>DS</sub> = 32 V	-	-	2.8	μΑ
I <sub>DSX</sub>	drain cut-off current	$V_{GS} = V_{GS(th)} + 3.75 V$	-	26.5	-	Α
I <sub>GSS</sub>	gate leakage current	V <sub>GS</sub> = 9 V; V <sub>DS</sub> = 0 V	-	-	280	nΑ
9 <sub>fs</sub>	forward transconductance	V <sub>DS</sub> = 10 V; I <sub>D</sub> = 7.2 A	-	15.0	-	S
R <sub>DS(on)</sub>	drain-source on-state resistance	$V_{GS} = V_{GS(th)} + 3.75 \text{ V};$ $I_D = 5.04 \text{ A}$	-	93	128	mΩ
Peak dev	rice					
V <sub>(BR)DSS</sub>	drain-source breakdown voltage	$V_{GS} = 0 \text{ V}; I_D = 2.98 \text{ mA}$	65	-	-	V
V <sub>GS(th)</sub>	gate-source threshold voltage	V <sub>DS</sub> = 10 V; I <sub>D</sub> = 298 mA	1.5	2.0	2.5	V
$V_{GSq}$	gate-source quiescent voltage	V <sub>DS</sub> = 28 V; I <sub>D</sub> = 1600 mA	-	2.2	-	V
I <sub>DSS</sub>	drain leakage current	V <sub>GS</sub> = 0 V; V <sub>DS</sub> = 32 V	-	-	2.8	μΑ
I <sub>DSX</sub>	drain cut-off current	$V_{GS} = V_{GS(th)} + 3.75 \text{ V}$	-	47	-	Α
I <sub>GSS</sub>	gate leakage current	V <sub>GS</sub> = 9 V; V <sub>DS</sub> = 0 V	-	-	280	nΑ
g <sub>fs</sub>	forward transconductance	V <sub>DS</sub> = 10 V; I <sub>D</sub> = 14.9 A	-	28.5	-	S
R <sub>DS(on)</sub>	drain-source on-state resistance	$V_{GS} = V_{GS(th)} + 3.75 \text{ V};$ $I_D = 10.43 \text{ A}$	-	50	74	mΩ

#### Table 7. RF characteristics

Test signal: 1-carrier W-CDMA; PAR = 9.6 dB at 0.01 % probability on the CCDF; 3GPP test model 1; 1 to 64 DPCH;  $f_1$  = 1807.5 MHz;  $f_2$  = 1877.5 MHz; RF performance at  $V_{DS}$  = 28 V;  $I_{Dq}$  = 800 mA (main);  $V_{GS(amp)peak}$  = 0.7 V;  $T_{case}$  = 25 °C; unless otherwise specified; in an asymmetrical Doherty production test circuit at frequencies from 1805 MHz to 1880 MHz.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Gp	power gain	P <sub>L(AV)</sub> = 56 W	14.7	15.7	-	dB
RLin	input return loss	P <sub>L(AV)</sub> = 56 W	-	-15	-10	dB
$\eta_{D}$	drain efficiency	P <sub>L(AV)</sub> = 56 W	45	49	-	%
ACPR	adjacent channel power ratio	P <sub>L(AV)</sub> = 56 W	-	-28	-23	dBc

#### Table 8. RF characteristics

Test signal: 1-carrier W-CDMA; PAR = 9.6 dB at 0.01 % probability on the CCDF; 3GPP test model 1; 1 to 64 DPCH; f = 1877.5 MHz; RF performance at  $V_{DS}$  = 28 V;  $I_{Dq}$  = 800 mA (main);  $V_{GS(amp)peak}$  = 0.7 V;  $T_{case}$  = 25 °C; unless otherwise specified; in an asymmetrical Doherty production test circuit at a frequency of 1880 MHz.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
PARO	output peak-to-average ratio	P <sub>L(AV)</sub> = 120 W	6.5	7.1	-	dB
P <sub>L(M)</sub>	peak output power	P <sub>L(AV)</sub> = 120 W	395	460	-	W

## 7. Test information

## 7.1 Ruggedness in Doherty operation

The BLC10G18XS-400AVT is capable of withstanding a load mismatch corresponding to VSWR = 10 : 1 through all phases under the following conditions:  $V_{DS}$  = 32 V;  $I_{Dq}$  = 800 mA;  $V_{GS(amp)peak}$  = 0.62 V; f = 1807.5 MHz;  $P_{L}$  = 185 W (5 dB OBO); 1-carrier W-CDMA, 100 % clipping.

## 7.2 Impedance information

Table 9. Typical impedance of main device

Measured load-pull data of main device;  $I_{Dq}$  = 800 mA (main);  $V_{DS}$  = 28 V; pulsed CW ( $t_p$  = 100  $\mu$ s;  $\delta$  = 10 %).

f	Z <sub>S</sub> [1]	Z <sub>L</sub> [1]	P <sub>L</sub> [2]	η <sub>D</sub> [2]	G <sub>p</sub> [2]				
(MHz)	(Ω)	(Ω)	(W)	(%)	(dB)				
Maximum	Maximum power load								
1800	1.1 – j5.0	1.2 – j2.9	200	61.0	17.0				
1845	1.2 – j5.4	1.3 – j2.8	200	62.0	17.5				
1880	1.5 – j5.8	1.1 – j2.8	200	58.5	17.0				
Maximum	drain efficiency	load							
1800	1.1 – j5.0	2.2 – j1.9	145	70.0	19.2				
1845	1.2 – j5.4	2.0 – j1.9	145	69.0	19.5				
1880	1.5 – j5.8	1.9 – j1.7	140	68.5	19.5				

<sup>[1]</sup>  $Z_S$  and  $Z_L$  defined in Figure 1.

<sup>[2]</sup> At 3 dB gain compression.

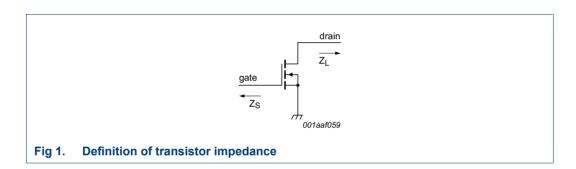
Table 10. Typical impedance of peak device

Measured load-pull data of peak device;  $I_{Dq}$  = 1600 mA (peak);  $V_{DS}$  = 28 V; pulsed CW ( $t_p$  = 100  $\mu$ s;  $\delta$  = 10 %).

f	Z <sub>S</sub> [1]	Z <sub>L</sub> [1]	P <sub>L</sub> [2]	η <sub>D</sub> [2]	G <sub>p</sub> [2]					
(MHz)	(Ω)	<b>(</b> Ω <b>)</b>	(W)	(%)	(dB)					
Maximum	Maximum power load									
1800	1.9 – j6.1	1.6 – j3.0	375	60.0	17.0					
1845	2.7 – j6.9	1.7 – j3.4	370	61.0	17.5					
1880	3.8 – j7.5	1.7 – j2.9	370	59.0	17.5					
Maximum	n drain efficiency	load								
1800	1.9 – j6.1	2.8 – j2.3	295	67.5	19.0					
1845	2.7 – j6.9	2.2 – j1.9	280	67.0	19.3					
1880	3.8 – j7.5	2.0 – j1.9	280	67.0	19.4					

<sup>[1]</sup>  $Z_S$  and  $Z_L$  defined in Figure 1.

<sup>[2]</sup> At 3 dB gain compression.



### 7.3 Recommended impedances for Doherty design

#### Table 11. Typical impedance of main at 1:1 load

Measured load-pull data of main device;  $I_{Dq}$  = 800 mA (main);  $V_{DS}$  = 28 V; pulsed CW ( $t_p$  = 100  $\mu$ s;  $\delta$  = 10 %).

f	Z <sub>S</sub> [1]	Z <sub>L</sub> [1]	P <sub>L</sub> [2]	η <sub>D</sub> [2]	G <sub>p</sub> [2]
(MHz)	<b>(</b> Ω <b>)</b>	<b>(</b> Ω <b>)</b>	(W)	(%)	(dB)
1800	1.2 – j4.6	1.7 – j3.2	170	38.0	21.0
1845	1.4 – j5.0	1.7 – j2.8	175	38.0	21.0
1880	1.5 – j5.2	1.6 – j2.8	170	39.5	21.5

<sup>[1]</sup>  $Z_S$  and  $Z_L$  defined in Figure 1.

<sup>[2]</sup> At  $P_{L(AV)} = 56 \text{ W}$ .

#### Table 12. Typical impedance of main device at 1: 2.5 load

Measured load-pull data of main device;  $I_{Dq}$  = 800 mA (main);  $V_{DS}$  = 28 V; pulsed CW ( $t_p$  = 100  $\mu$ s;  $\delta$  = 10 %).

f	Z <sub>S</sub> [1]	Z <sub>L</sub> [1]	P <sub>L</sub> [2]	η <sub>D</sub> [2]	G <sub>p</sub> [2]
(MHz)	<b>(</b> Ω <b>)</b>	<b>(</b> Ω <b>)</b>	(W)	(%)	(dB)
1800	1.1 – j4.6	3.7 – j1.3	85	54.5	23.5
1845	1.2 – j5.0	3.4 – j1.0	75	54.5	24.0
1880	1.3 – j5.4	3.2 – j0.5	70	54.5	24.0

<sup>[1]</sup>  $Z_S$  and  $Z_L$  defined in Figure 1.

#### Table 13. Typical impedance of peak device at 1:1 load

Measured load-pull data of peak device;  $I_{Dq}$  = 1600 mA (peak);  $V_{DS}$  = 28 V; pulsed CW ( $t_p$  = 100  $\mu$ s;  $\delta$  = 10 %).

f	Z <sub>S</sub> [1]	Z <sub>L</sub> [1]	P <sub>L</sub> [2]	η <sub>D</sub> [2]	G <sub>p</sub> [2]
(MHz)	<b>(</b> Ω <b>)</b>	<b>(</b> Ω <b>)</b>	(W)	(%)	(dB)
1800	1.9 – j5.6	2.6 – j3.4	300	27.5	21.0
1845	2.5 – j6.2	2.6 – j3.0	300	27.0	21.0
1880	3.3 – j6.5	2.5 – j2.7	295	27.5	21.5

<sup>[1]</sup>  $Z_S$  and  $Z_L$  defined in Figure 1.

Table 14. Off-state impedances of peak device

f	Z <sub>off</sub>
(MHz)	(Ω)
1800	1.4 – j2.8
1845	0.9 – j1.7
1880	0.7 – j1.0

<sup>[2]</sup> At  $P_{L(AV)} = 56 \text{ W}$ .

<sup>[2]</sup> At  $P_{L(AV)} = 56 \text{ W}$ .

#### 7.4 Test circuit

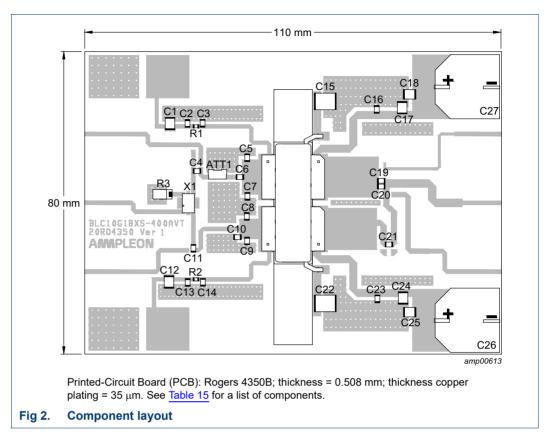


Table 15. List of components

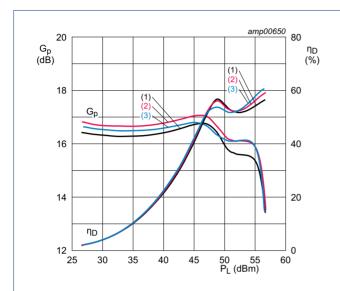
See <u>Figure 2</u> for compo			
Component	Description	Value	Remarks
C1, C12, C17, C18, C24, C25	multilayer ceramic chip capacitor	4μF, 50 V	Murata: GRM32ER71H475KA88L, SMD 1210
C2, C13	multilayer ceramic chip capacitor	100 nF, 50 V	Murata: SMD 805
C3, C4, C6, C11, C14, C16, C21, C23	multilayer ceramic chip capacitor	18 pF	Murata: HiQ, SMD 0805
C5	multilayer ceramic chip capacitor	2.7 pF	Murata: HiQ, SMD 0805
C7	multilayer ceramic chip capacitor	2.4 pF	Murata: HiQ, SMD 0805
C8	multilayer ceramic chip capacitor	1.6 pF	Murata: HiQ, SMD 0805
C9	multilayer ceramic chip capacitor	1.5 pF	Murata: HiQ, SMD 0805
C10	multilayer ceramic chip capacitor	1.3 pF	Murata: HiQ, SMD 0805
C15, C22	multilayer ceramic chip capacitor	4.7 μF, 100 V	C5750X7R2A475KT/A
C19, C20	multilayer ceramic chip capacitor	3.0 pF	Murata: HiQ, SMD 0805
C26, C27	electrolytic capacitor	470 μF, 63 V	EEVFK1J471M
R1, R2	resistor	4.7 Ω, 1 %	SMD 805
R3	resistor	50 Ω, 25 W	Anaren: C16A50Z4
X1	hybrid coupler	2 dB, 90°	Anaren: Xinger III, X3C20F1-02
ATT1	attenuator	1 dB	Anaren: D10AA1Z4

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### 7.5 Graphical data

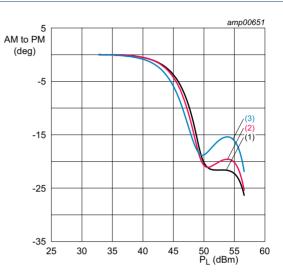
### 7.5.1 Pulsed CW



 $V_{DS} = 28 \text{ V}; I_{Dq} = 800 \text{ mA}; V_{GS(amp)peak} = 0.7 \text{ V}.$ 

- (1) f = 1805 MHz
- (2) f = 1842.5 MHz
- (3) f = 1880 MHz

Fig 3. Power gain and drain efficiency as function of output power; typical values



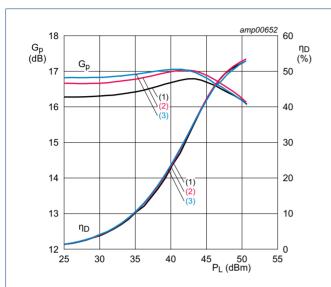
 $V_{DS}$  = 28 V;  $I_{Dq}$  = 800 mA;  $V_{GS(amp)peak}$  = 0.7 V.

- (1) f = 1805 MHz
- (2) f = 1842.5 MHz
- (3) f = 1880 MHz

Fig 4. Normalized AM to PM as a function of output power; typical values

#### 7.5.2 1-Carrier W-CDMA

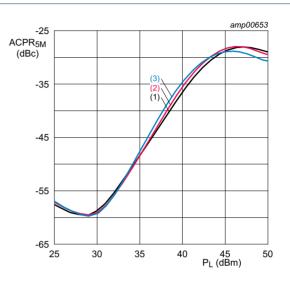
Test signal: 3GPP test model 1; 1 to 64 DPCH (100 % clipping): PAR = 7.5 dB per carrier at 0.01 % probability on CCDF per carrier.



 $V_{DS}$  = 28 V;  $I_{Dq}$  = 800 mA;  $V_{GS(amp)peak}$  = 0.7 V.

- (1) f = 1805 MHz
- (2) f = 1842.5 MHz
- (3) f = 1880 MHz

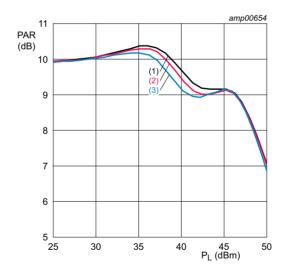
Fig 5. Power gain and drain efficiency as function of output power; typical values



 $V_{DS} = 28 \text{ V}; I_{Dq} = 800 \text{ mA}; V_{GS(amp)peak} = 0.7 \text{ V}.$ 

- (1) f = 1805 MHz
- (2) f = 1842.5 MHz
- (3) f = 1880 MHz

Fig 6. Adjacent channel power ratio (5 MHz) as a function of output power; typical values



 $V_{DS}$  = 28 V;  $I_{Dq}$  = 800 mA;  $V_{GS(amp)peak}$  = 0.7 V.

- (1) f = 1805 MHz
- (2) f = 1842.5 MHz
- (3) f = 1880 MHz

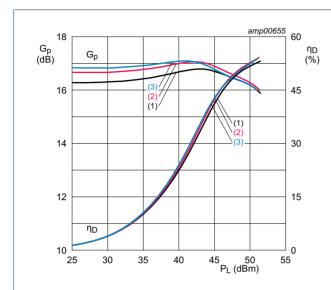
Fig 7. Peak-to-average power ratio as a function of output power; typical values

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#### 7.5.3 2-Carrier W-CDMA

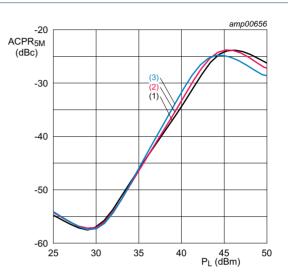
Test signal: 3GPP test model 1; 1 to 64 DPCH (46 % clipping): PAR = 7.5 dB per carrier at 0.01 % probability on CCDF per carrier.



 $V_{DS}$  = 28 V;  $I_{Dq}$  = 800 mA;  $V_{GS(amp)peak}$  = 0.7 V.

- (1) f = 1805 MHz
- (2) f = 1842.5 MHz
- (3) f = 1880 MHz

Fig 8. Power gain and drain efficiency as function of output power; typical values

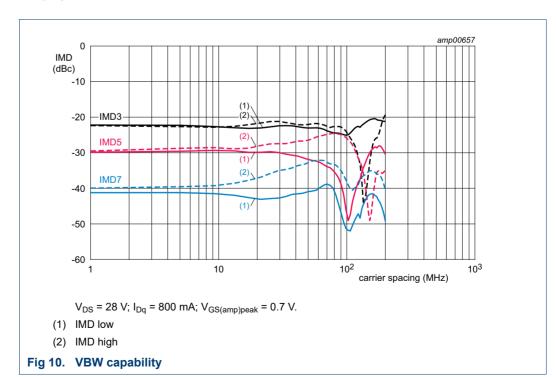


 $V_{DS} = 28 \text{ V}; I_{Dq} = 800 \text{ mA}; V_{GS(amp)peak} = 0.7 \text{ V}.$ 

- (1) f = 1805 MHz
- (2) f = 1842.5 MHz
- (3) f = 1880 MHz

Fig 9. Adjacent channel power ratio (5 MHz) as a function of output power; typical values

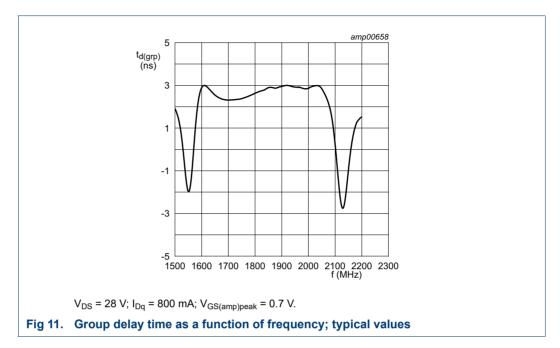
#### 7.5.4 2-Tone VBW



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### 7.5.5 Group delay



# 8. Package outline

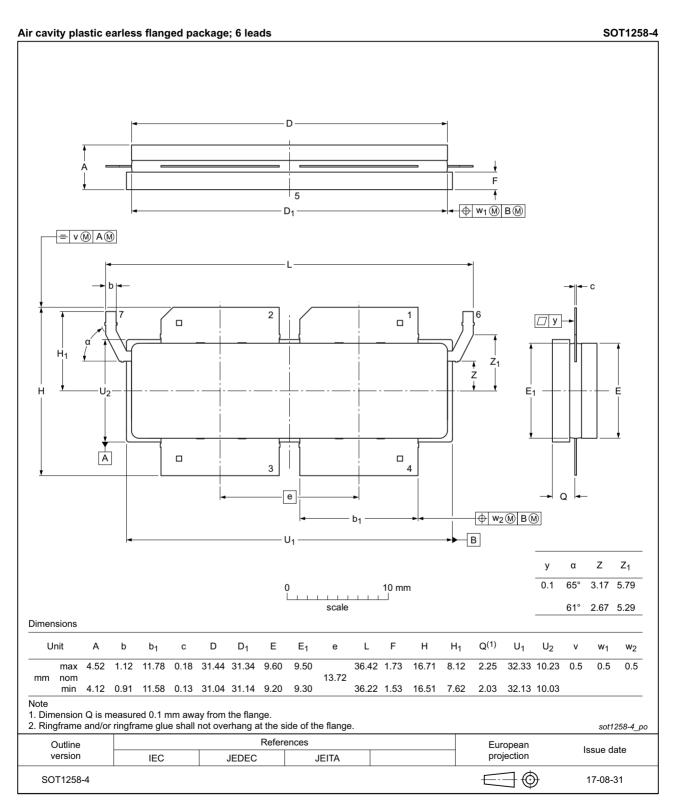


Fig 12. Package outline SOT1258-4

# 9. Handling information

#### **CAUTION**



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices.

Such precautions are described in the ANSI/ESD S20.20, IEC/ST 61340-5, JESD625-A or equivalent standards.

Table 16. ESD sensitivity

ESD model	Class
Charged Device Model (CDM); According to ANSI/ESDA/JEDEC standard JS-002	C3 [1]
Human Body Model (HBM); According to ANSI/ESDA/JEDEC standard JS-001	2 [2]

- [1] CDM classification C3 is granted to any part that passes after exposure to an ESD pulse of 1000 V.
- [2] HBM classification 2 is granted to any part that passes after exposure to an ESD pulse of 2000 V, but fails after exposure to an ESD pulse of 4000 V.

### 10. Abbreviations

Table 17. Abbreviations

Acronym	Description
3GPP	3rd Generation Partnership Project
CCDF	Complementary Cumulative Distribution Function
CW	Continuous Wave
DPCH	Dedicated Physical CHannel
ESD	ElectroStatic Discharge
LDMOS	Laterally Diffused Metal-Oxide Semiconductor
MTF	Median Time to Failure
ОВО	Output Back Off
PAR	Peak-to-Average Ratio
RoHS	Restriction of Hazardous Substances
SMD	Surface Mounted Device
VSWR	Voltage Standing Wave Ratio
W-CDMA	Wideband Code Division Multiple Access

# 11. Revision history

Table 18. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BLC10G18XS-400AVT v.1	20180419	Product data sheet	-	-

## 12. Legal information

#### 12.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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For more information, please visit: http://www.ampleon.com

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#### **Power LDMOS transistor**

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